STGW30NC120HD

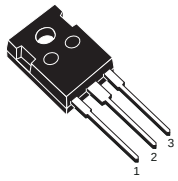
N-CHANNEL 30A - 1200V - TO-247
VERY FAST PowerMESH™ IGBT

TARGET SPECIFICATION

General features

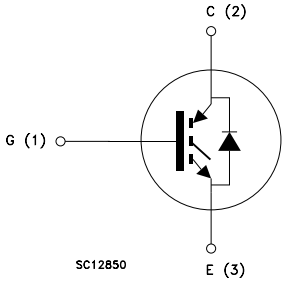
Type	V_{CES}	$V_{CE(sat)}$ (Max) @ 25°C	I_C
STGW30NC120HD	1200V	< 2.8V	30A

- LOW ON-LOSSES
- LOW ON-VOLTAGE DROP (V_{cesat})
- HIGH CURRENT CAPABILITY
- HIGH INPUT IMPEDANCE (VOLTAGE DRIVEN)
- LOW GATE CHARGE
- VERY HIGH FREQUENCY OPERATION
- LATCH CURRENT FREE OPERATION



TO-247

Internal schematic diagram



Description

Using the latest high voltage technology based on its patented strip layout, STMicroelectronics has designed an advanced family of IGBTs, with outstanding performances. The suffix “H” identifies a family optimized for high frequency application in order to achieve very high switching performances (reduced tfall) mantaining a low voltage drop.

Applications

- HIGH FREQUENCY MOTOR CONTROL
- U.P.S
- WELDING EQUIPMENT
- INDUCTION HEATING

Order codes

Sales Type	Marking	Package	Packaging
STGW30NC120HD	GW30NC120HD	TO-247	TUBE

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{CES}	Collector-Emitter Voltage (V_{GS} = 0)	1200	V
I_C *Note* 2	Collector Current (continuous) at 25°C	60	A
I_C *Note* 2	Collector Current (continuous) at 100°C	30	A
I_{CM} *Note* 1	Collector Current (pulsed)	120	A
V_{GE}	Gate-Emitter Voltage	± 20	V
P_{TOT}	Total Dissipation at T_C=25°C	200	W
I_f	Diode RMS Forward Current at T_C=25°C	200	
T_j	Operating Junction Temperature	– 55 to 150	°C
T_{stg}	Storage Temperature		

Table 2. Thermal resistance

		Min.	Typ.	Max.	Unit
Rthj-case	Thermal Resistance Junction-case	--	--	0.625	°C/W
Rthj-amb	Thermal Resistance Junction-ambient	--	--	50	°C/W

2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

Table 3. Static

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{BR(CES)}$	Collectro-Emitter Breakdown Voltage	I_C = 250µA, V_{GE} = 0	1200			V
$V_{CE(SAT)}$	Collector-Emitter Saturation Voltage	V_{GE}= 15V, I_C= 20A, Tj= 25°C V_{GE}= 15V, I_C= 20A, Tj= 125°C		2.4 2	2.9	V V
$V_{GE(th)}$	Gate Threshold Voltage	V_{CE}= V_{GE}, I_C= 250µA	5		7	V
I_{CES}	Collector-Emitter Leakage Current (V_{CE} = 0)	V_{GE} =Max Rating,Tc=25°C V_{GE} =Max Rating, Tc=125°C			10 100	µA µA
I_{GES}	Gate-Emitter Leakage Current (V_{CE} = 0)	V_{GE} =± 20V , V_{CE} = 0			± 100	nA
g_{fs}	Forward Transconductance	V_{CE} = 25V, I_C= 25A		TBD		S

Table 4. Dynamic

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
C_{ies} C_{oes} C_{res}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	V_{CE} = 25V, f = 1 MHz, V_{GE} = 0		TBD TBD TBD		pF pF pF
Qg Qge Qgc	Total Gate Charge Gate-Emitter Charge Gate-Collector Charge	V_{CE} =960V, I_C=20A,V_{GE} =15V		TBD TBD TBD	TBD	nC nC nC

Table 5. Switching on/off (inductive load)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$ t_r $(di/dt)_{on}$	Turn-on Delay Time Current Rise Time Turn-on Current Slope	V_{CC} = 960V, I_C = 20A R_G= 10Ω, V_{GE}= 15V, Tj= 25°C (see Figure 3)		TBD 62 TBD		ns ns A/µs
$t_{d(on)}$ t_r $(di/dt)_{on}$	Turn-on Delay Time Current Rise Time Turn-on Current Slope	V_{CC} = 960V, I_C = 20A R_G= 10Ω, V_{GE}= 15V, Tj= 125°C (see Figure 3)		TBD TBD TBD		ns ns A/µs
$t_r(V_{off})$ $t_{d(off)}$ t_f	Off Voltage Rise Time Turn-off Delay Time Current Fall Time	V_{CC} = 960V, I_C = 20A R_G= 10Ω, V_{GE}= 15V, Tj= 25°C (see Figure 3)		TBD TBD TBD		ns ns ns
$t_r(V_{off})$ $t_{d(off)}$ t_f	Cross-over Time Off Voltage Rise Time Turn-off Delay Time Current Fall Time	V_{CC} = 960V, I_C = 20A R_G= 10Ω, V_{GE}= 15V, Tj= 125°C (see Figure 3)		TBD TBD TBD		ns ns ns

Table 6. Switching energy (inductive load)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Eon *Note* 3 E_{off} *Note* 4 E_{ts}	Turn-on Switching Losses Turn-off Switching Losses Total Switching Losses	V_{CC} = 960V, I_C = 20A R_G= 10Ω, V_{GE}= 15V, Tj= 25°C (see Figure 3)		TBD TBD TBD		µJ µJ µJ
Eon *Note* 3 E_{off} *Note* 4 E_{ts}	Turn-on Switching Losses Turn-off Switching Losses Total Switching Losses	V_{CC} = 960V, I_C = 20A R_G= 10Ω, V_{GE}= 15V, Tj= 125°C (see Figure 3)		TBD TBD TBD		µJ µJ µJ

Table 7. Collector-emitter diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
V_f	Forward On-Voltage	If = 12A If = 12A, Tj = 125 °C		2.4 1.4	2.9	V V
t_{rr} Q_{rr} I_{rrm}	Reverse Recovery Time Reverse Recovery Charge Reverse Recovery Current	If = 12A, V_R = 27V, T_j = 125 °C, di/dt = 100A/µs (see Figure 4)		TBD TBD TBD		ns nC A

(1)Pulse width limited by max junction temperature

(2) Calculated according to the iterative formula:

$$I_C(T_C) = \frac{T_{JMAX} - T_C}{R_{THJ-C} \times V_{CESAT(MAX)}(T_C, I_C)}$$

(3) Eon is the turn-on losses when a typical diode is used in the test circuit in figure 2. If the IGBT is offered in a package with a co-pack diode, the co-pack diode is used as external diode. IGBTs & Diode are at the same temperature (25°C and 125°C)

(4) Turn-off losses include also the tail of the collector current

3 Test Circuits

Figure 1. Test Circuit for Inductive Load Switching

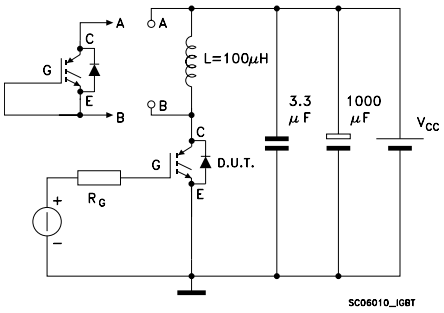


Figure 2. Gate Charge Test Circuit

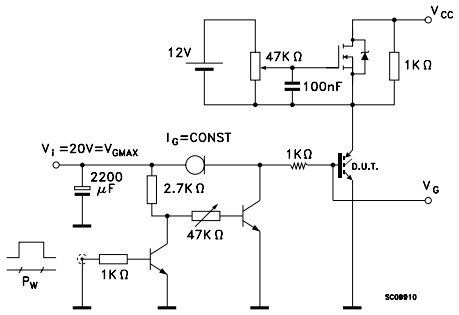


Figure 3. Switching Waveform

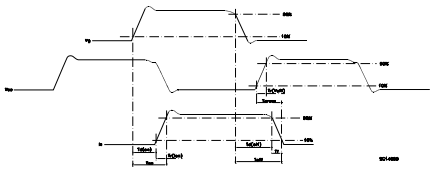
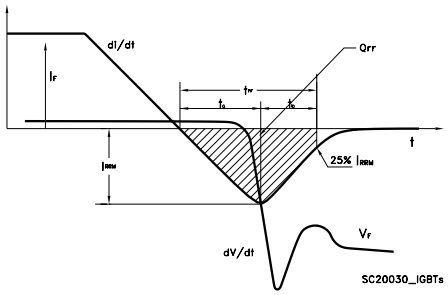


Figure 4. Diode Recovery Time Waveform

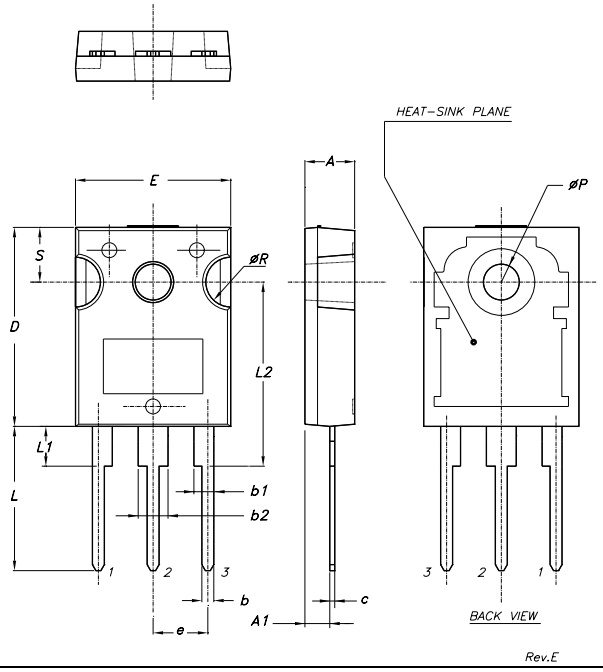


4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

TO-247 MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A	4.85		5.15	0.19		0.20
A1	2.20		2.60	0.086		0.102
b	1.0		1.40	0.039		0.055
b1	2.0		2.40	0.079		0.094
b2	3.0		3.40	0.118		0.134
c	0.40		0.80	0.015		0.03
D	19.85		20.15	0.781		0.793
E	15.45		15.75	0.608		0.620
e		5.45			0.214	
L	14.20		14.80	0.560		0.582
L1	3.70		4.30	0.14		0.17
L2		18.50			0.728	
øP	3.55		3.65	0.140		0.143
øR	4.50		5.50	0.177		0.216
S		5.50			0.216	



5 Revision History

Date	Revision	Changes
14-Nov-2005	1	Initial release.